Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
09/924,310	HAN ET AL.
Examiner	Art Unit
Md S. Elahee	2645

	SEAR	CHED	
Class	Subclass	Date	Examiner
379	266.07	8/19/2005	M.E.
340	996		

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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	V 10		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East	8/19/2005	M.E.
Consulted with Benny Tieu	8/15/2005	M.E.
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704/245 (text search only-see East search history printout)	8/16/2005	M.E.
707/6,379/88.11(text search only-see East search history printout)	8/19/2005	M.E.